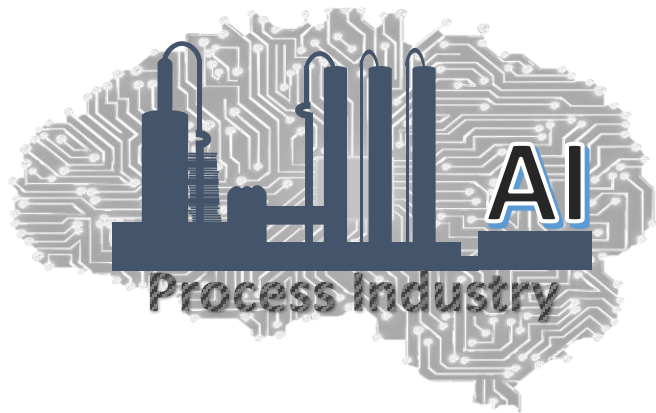


Statistical Techniques for Monitoring Industrial Processes

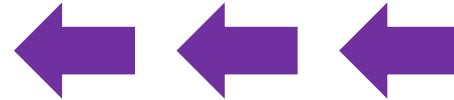


Lecture : PLS – Under the Hood

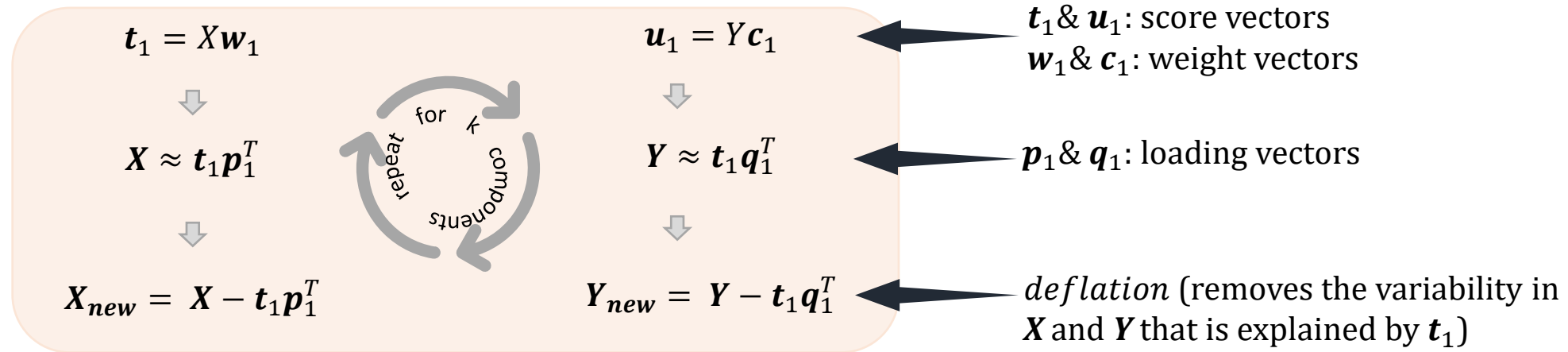
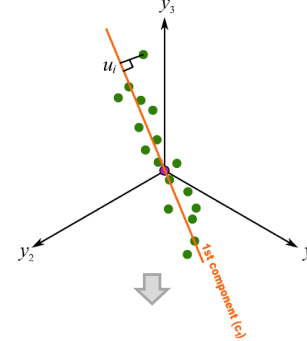
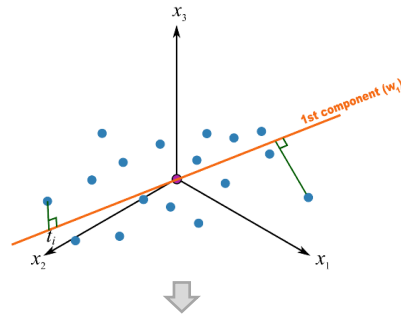
Module : PLS-based MSPM

Course TOC

- ❑ Introduction to Statistical Process Monitoring (SPM)
- ❑ Python Installation and basics (optional)
- ❑ Univariate SPM & Control Charts
 - Shewhart Charts
 - CUSUM Charts
 - EWMA Charts
- ❑ Multivariate SPM
 - Principal Component Analysis (PCA)-based MSPM
 - Partial Least Squares (PLS) regression-based MSPM
 - Fault detection & diagnosis (FDD) using PLS
 - Application to a LDPE reactor monitoring
 - Strategies for handling nonlinear, dynamic, multimode systems
- ❑ Deploying SPM solutions



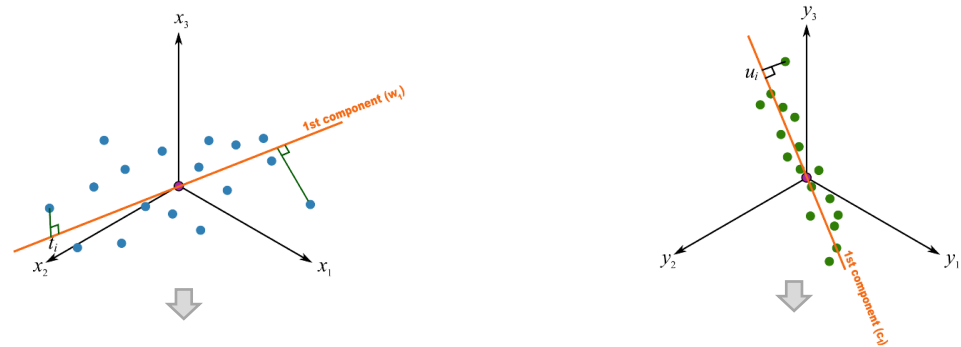
PLS Regression: Score / Weight / Loading Vectors



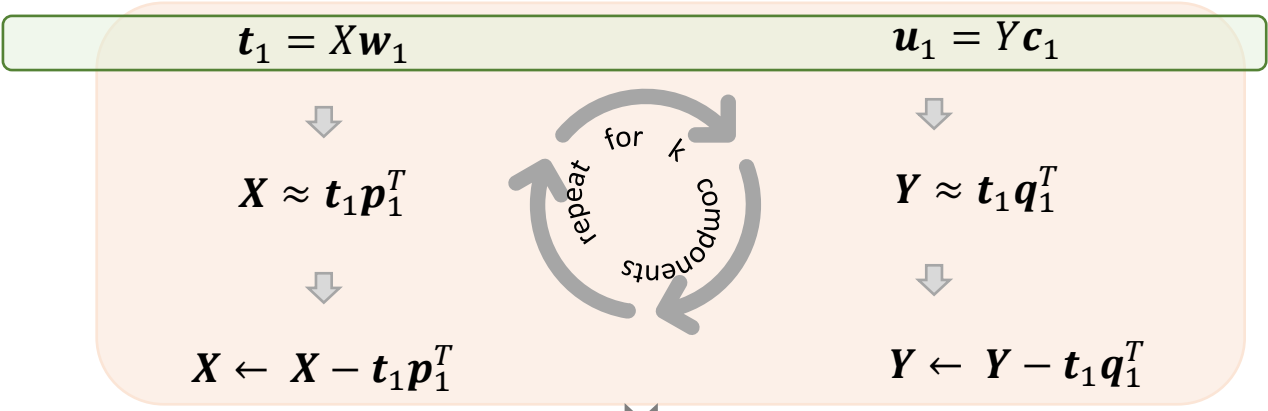
$$X = \sum_{i=1}^k t_i p_i^T + E$$

$$Y = \sum_{i=1}^k t_i q_i^T + F \quad \leftarrow \text{PLS decomposition}$$

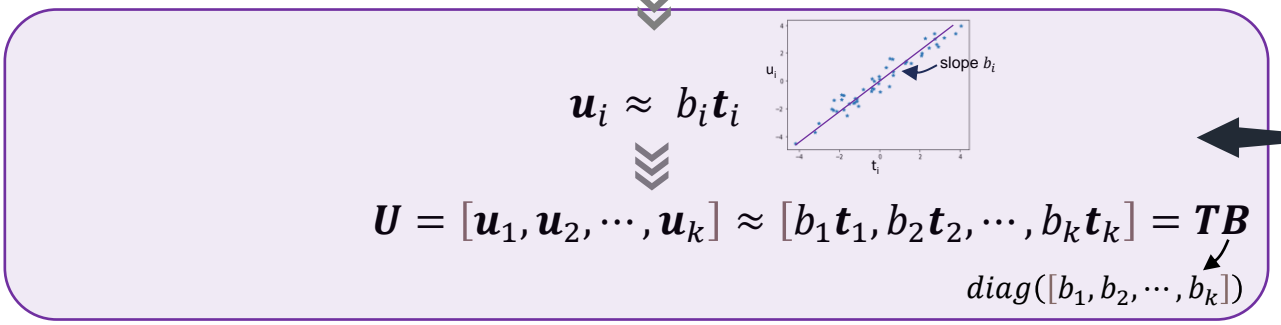
PLS: Outer and Inner Relations



Outer relations



Inner relations



helps to estimate U and eventually Y ($\approx \hat{U}Q^T = TBQ^T$) using only input variables

PLS: Rotation Vectors / Projection Matrix

Can we write: $T \overset{\text{X}}{X} W$?

$$t_i \neq Xw_i ; i > 2$$

Instead, we can write: $T = XR$
 \searrow
 $R = W(P^T W)^{-1}$

PLS VS PCA: Fault Detection Metrics

PCA

● $T = XP$
→ T^2 metrics

● $E = X - \hat{X}$
→ SPE metrics

PLS

● $T = XR$
→ T^2 metrics

Captures systematic variations

● $E_x = X - \hat{X}$
→ SPE_x metrics

Captures noise in input variables

● $E_y = Y - \hat{Y}$
→ SPE_y metrics

Captures noise in output variables

Statistical Techniques for Monitoring Industrial Processes



Next Lecture : PLS Modeling of LDPE Reactor

Module : PLS-based MSPM

